

**Search Notes****Application/Control No.**

09/832,010

**Examiner**

Pablo N. Tran

**Applicant(s)/Patent under Reexamination**

SMITH ET AL.

**Art Unit**

2618

**SEARCHED**

Class	Subclass	Date	Examiner
455	466		
	461		
	412.1 - 412.2		
	414.1		
	413		
	556.1		
	557		
	867		
	417		
	445		
	432.2		
379	52		
	90.07		
	93.05		

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

Search Notes (continued)	Application/Control No.	Applicant(s)/Patent under Reexamination
	09/832,010	SMITH ET AL.
Examiner	Art Unit	
Pablo N. Tran	2618	

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner